## CURRENT SOURCE AND NANOVOLTMETER

## FOR THIN FILM RESISTIVITY MEASUREMENT

## **Technical specifications**

Sl. No.	PARAMETERS / PARTICULARS REQUIRED
1	General requirements:
	System should have the capability to precisely source current as well as measure
	voltage for measurement of a wide range of resistances from few m $\Omega$ to ~10 G $\Omega$ .
2	Current source should have the following capabilities:
	• Arbitrary waveform Amplitude: at least from 5pA to 200mA peak-peak into loads up to $10^{12} \Omega$
	• Resolution at least 100 fA for the range of 2 nA or better
	• Voltage Compliance: ~-100 V (Better lower range and steps are preferred)
	• Output Impedance: $\sim 10^{14} \Omega$
	Should have built-in guarded sourcing for faster low current
	Automatic reversal of current should be provided
	Waveforms: Sine, Square, Ramp, and 4 user defined arbitrary waveforms
	Frequency range: 1mHz to 100kHz
3	Voltmeter should have the following capabilities:
	• 7(1/2) Digits Display Resolution
	<ul> <li>Lower resolution: 1nV resolution @ 10 mV range or better</li> </ul>
	• Noise @ 60 msec response (lowest range) <100 nV p-p
	<ul> <li>Accuracy @ 10 mV/ 90 day ~50 ppm + 40 nV</li> </ul>
	<ul> <li>Dual channels (Maximum range Ch1 100V and Ch2 10 V)</li> </ul>
	• Input Resistance should be >10 G $\Omega$ (~ 10 M $\Omega$ for 100 V range).
	Ratio mode should be available.
4	Both systems should have GPIB and Ethernet communication facility
5	All necessary low noise cables and accessories for electrical measurement should be provided.
6	System should have capability of Low current sourcing (pA range), resistance measurement (m $\Omega$ to ~10 G $\Omega$ ), conductance measurement, differential conductance
	measurement.
7	Warranty: 3 years

## **ELIGIBILITY CRITERIA:**

• OEM should have authorized service centre in India, functioning minimum for 10 years to provide repair, maintenance, calibration and upgradation facility (OEM should provide necessary service of operation certificate).